

Search Notes

Application/Control No.

10/714,836

Examiner

Lorna M. Douyon

Applicant(s)/Patent under
Reexamination

WEI ET AL.

Art Unit

1751

SEARCHED

Class	Subclass	Date	Examiner
510	445	6/25/2006	LMD
510	446	6/25/2006	LMD
510	224	6/25/2006	LMD
510	233	6/25/2006	LMD
510	469	6/25/2006	LMD
510	480	6/25/2006	LMD
510	509	6/25/2006	LMD
510	511	6/25/2006	LMD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/25/2006	LMD